National Institute of Advanced Manufacturing Technology Central Instrument Facility

Requisition form for X-Ray Diffraction: Residual Stress Analysis (CPDA users)

| | | | | | | Date: | | | | |
|--|------------------|-------------|---------------|---------------|-------|--|------------------|-----------------------------|-----------------------|--|
| Name of the user: | | | | | | Name of the supervisor: | | | | |
| Course: Ph.D. / M. Tech / B. Tech / ADC | | | | | | Department: | | | | |
| Contact No. | | | | | | No. of Samples submitted: | | | | |
| Email ID: | | | | | | Nature of samples: Hazardous / Non-hazardous | | | | |
| Test/s to be done: Please provide the following details: | | | | | | | | | | |
| S | Sample | Material | | Scan | | hkl | Young's | Poisson's | Sample | |
| No. | Name | Name | free angle | Range 2θ=_to_ | | value | modulus (MPa) | ratio (v) | Recollection (Yes/No) | |
| | | | | | | | | | | |
| | | | | | | | | | | |
| L Rema | l rks, if any | <u> </u> | | | | | | | | |
| Payment Details | | | | | | | | | | |
| No. of samples/test to be done: | | | | | | | | | | |
| No. of 30 min. slot required: | | | | | | | | | | |
| | l Amount | , , | | | | | | | | |
| Tota | l amount t | to be deduc | ted from | CPD | OA of | f Prof./I |)r | | | |
| Details are entered in CPDA register book at page No and serial no | | | | | | | | | | |
| Signature of user Signature of su | | | | | | | Signature of HOD | | | |
| | | | For Cl | F office | use - | – XRD I | Facility | | | |
| Details are entered in XRD lab register book at page no | | | | | | | and s | and serial no | | |
| Date of Completion: | | | | | | | _ | Signature of Technician | | |
| Amou | | ansferred I | | | | | | | | |
| | | | | | | | Signatu | Signature of Chairman – CIF | | |

Note: Duly filled SP-02 form needs to be attached with this requisition form.